

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10582503	IMANAKA ET AL.
	<b>Examiner</b> ALEXANDER C WITKOWSKI	<b>Art Unit</b> 2853

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
347	9, 12, 17, 19, 43, 48, 49, 50, 54, 56, 58, 59, 65.	01/12/2009	ACW
358	296	01/12/2009	ACW
422	100	01/12/2009	ACW
439	181	01/12/2009	ACW

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Stephen D. Meier, Supervisory Patent Examiner.	09/24/2008	ACW
Limited classification search: 347/ 62, 64	09/24/2008	ACW
Text search. See search history.	09/24/2008	ACW
Julian Huffman, Primary Examiner	01/12/2009	ACW
Juanita Stevens, Primary Examiner	01/15/2009	ACW
Limited classification search: 347/ 9, 12, 17, 19, 43, 48, 49, 50, 54, 56, 58, 59, 65; 358/ 296; 422/ 100; 439/ 181.	01/12/2009	ACW
Text search. See search history.	01/12/2009	ACW

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
347	9, 12, 17, 19, 43, 48, 49, 50, 54, 56, 58, 59, 65.	01/19/2009	ACW

/A. C. W./  
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